## Applicant(s)/Patent Under Application/Control No. Reexamination 09/965,370 CHUNG ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Eric B Fuller 1762 **U.S. PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Name Classification MM-YYYY Α US-2002/0086523 07-2002 Barth et al. 438/637 US-2002/0127845 09-2002 FARRAR, PAUL A. 438/627 В С US-6,290,833 09-2001 Chen, Linlin 205/182 07-2002 205/184 D US-2002/0088716 Pavate et al. US-6,294,425 09-2001 Hideki, Horii 438/253 Ε US-6,534,133 03-2003 Kaloyeros et al. 427/576 G US-6,218,302 04-2001 Braeckelmann et al. 438/687 09-2002 428/635 Н US-6,447,933 Wang et al. ſ US-J US-US-Κ 1 US-US-Μ FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т NON-PATENT DOCUMENTS Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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